Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/038,344	ZHANG ET AL.	
Examiner	Art Unit	
Nathan Erb	3639	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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